

Notice of References Cited	Application/Control No. 09/055,984	Applicant(s)/Patent Under Reexamination KIM, TAE WOON	
	Examiner Toan D Nguyen	Art Unit 2665	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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	B	US-6,415,410B1	07-2002	Kanerva et al.	714/749
	C	US-5,915,222	06-1999	Olsson et al.	455/466
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	A	US-5,590,133	12-1996	Billstrom et al.	370/349
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